Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/795,915	CHANG ET AL.
Examiner	Art Unit
Kara E. Geisel	2877

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Class	Subclass	Date	Examiner
356	237.1	6/21/2006	KG
702	155		
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
·	DATE	EXMR
356/337-343,626-627, 237.1, 239.3,239.7, 237.5 (text search only) See search history printout.	6/21/2006	· KG
702/35,40,155-157, 166-167 (text search only) See search history printout.	·	
EAST (EPO JPO DERWENT USPAT USPGPUB) See search history printout.		•
Google Scholar. See search history printout.		
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